

# MOS FIELD EFFECT TRANSISTOR 2SJ581

# SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

### **DESCRIPTION**

The 2SJ581 is P-Channel DMOS Field Effect Transistor that features a low on-resistance and excellent switching characteristics, designed for high current switching applications such as DC to DC converter and load switch.

### ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ581	MP-10

### **FEATURES**

• Low on-state resistance :

RDS(on)1 =  $70 \text{ m}\Omega$  TYP. (VGS = -10 V, ID = -6 A)

RDS(on)2 = 120 m $\Omega$  TYP. (VGS = -4 V, ID = -6 A)

• Low input capacitance:

 $C_{iss} = 1210 pF TYP. (V_{DS} = -10 V, f = 1MHz)$ 

• Narrow gate cut-off voltage width :

 $V_{GS(off)} = -1.0 \text{ to } -2.0 \text{ V}$ 

- Built-in gate protection diode.
- Suitable to automatically assembling.

**Note** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1 %

# ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage	VDSS	-60	V
Gate to Source Voltage	VGSS(AC)	±20	V
Gate to Source Voltage	VGSS(DC)	-20, 0	V
Drain Current (DC)	ID(DC)	±12	Α
Drain Current (pulse) Note	D(pulse)	±48	Α
Total Power Dissipation (T <sub>A</sub> = 25 °C)	Рт	1.8	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



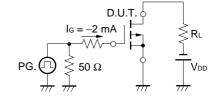
**ELECTRICAL CHARACTERISTICS(TA = 25°C)** 

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Leakage Current	IDSS	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V			-10	μΑ
Gate Leakage Current	lgss	Vgs = ±10 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -1.0 \text{ mA}$	-1.0		-2.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -6 A	5.0			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = -10 V, ID = -6 A		70	100	mΩ
	RDS(on)2	Vgs = -4 V, ID = -6 A		120	185	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = −10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1210		pF
Output Capacitance	Coss			520		pF
Reverse Transfer Capacitance	Crss			180		pF
Turn-on Delay Time	t <sub>d(on)</sub>	$I_D = -6 \text{ A}, V_{GS(on)} = -10 \text{ V},$		15		ns
Rise Time	tr	$V_{DD} = -30 \text{ V},$		130		ns
Turn-off Delay Time	<b>t</b> d(off)	$R_G = 10 \Omega$		95		ns
Fall Time	t <sub>f</sub>			80		ns
Total Gate Charge	Q <sub>G</sub>	$I_D = -12 \text{ A}, V_{DD} = -48 \text{ V},$		42		nC
Gate to Source Charge	Qgs	$V_{GS(on)} = -10 \text{ V}$		8.0		nC
Gate to Drain Charge	Q <sub>GD</sub>			10		nC
Diode Forward Voltage	V <sub>F</sub> (S-D)	IF = -12 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = -12 A, VGS = 0 V,		120		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		230		nC

# **TEST CIRCUIT 1 SWITCHING TIME**

# PG. $\bigcap_{RG} RG = 10 \Omega$ $\tau = 1 \mu s$ D.U.T. $\bigcap_{RG} RG = 10 \Omega$ $\nabla_{GS}(-) \bigcap_{U} \nabla_{GS}(-) \bigcap_{U}$

# **TEST CIRCUIT 2 GATE CHARGE**



90 %

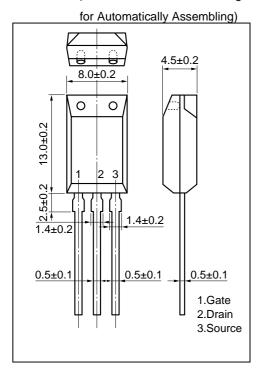
90 %

10 %

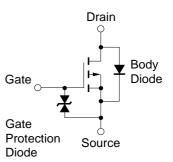


# PACKAGE DRAWING (Unit: mm)

MP-10 (Isolated TO-220 class Package



## **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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